

Amendments to the Claims

This listing of the claims will replace all prior versions and listings of claims in the application.

Listing of Claims:

1-24. (cancelled)

25. (currently amended) A processing method for a fuse structure, the method comprising the steps of:

 providing a structure;

 forming a first conductive layer and a second conductive layer on part of the structure;

 forming a first dielectric layer on the first conductive layer, the second conductive layer and the structure;

 forming a first opening on the first dielectric layer, exposing the first conductive layer and the second conductive layer;

 implanting forming a first conductive plug in the first opening to contact to penetrate the first conductive layer via the first opening;

 forming a third conductive layer and a fourth conductive layer on part of the first dielectric layer;

 forming a second dielectric layer on the third conductive layer, the fourth conductive layer and the first dielectric layer;

 forming a second opening on the second dielectric layer, exposing the first opening, the third conductive layer and the fourth conductive layer;

 implanting forming the a second conductive plug in the second opening to contact the third conductive layer to penetrate the second dielectric layer via the second opening;

 forming a fifth conductive layer, a sixth conductive layer, a seventh conductive layer, an eighth conductive layer, a ninth conductive layer and a tenth conductive layer on part of the second dielectric layer, wherein a third conductive plug is electrically connected to the fourth conductive layer

and the fifth conductive layer, a fourth conductive plug is electrically connected to the second conductive layer and the sixth conductive layer, the third conductive layer is electrically connected to the ninth conductive layer and the eighth conductive layer is electrically connected to the first conductive layer.

26. (currently amended) A processing method for a fuse structure, the method comprising the steps of:

forming a substrate;

forming a eleventhfirst conductive layer, a twelfthsecond conductive layer, a thirteenththird conductive layer and a fourteenthfourth conductive layer on part of the substrate;

forming a first dielectric layer on the eleventhfirst conductive layer, the twelfthsecond conductive layer, the thirteenththird conductive layer, the fourteenthfourth conductive layer and the substrate;

forming a fifteenthfifth conductive layer, a sixteenthsixth conductive layer, a seventeenthseventh conductive layer, an eighteentheighth conductive layer on part of the first dielectric layer;

forming a second dielectric layer on the fifteenthfifth conductive layer, the sixteenthsixth conductive layer, the seventeenthseventh conductive layer, the eighteentheighth conductive layer and the first dielectric layer;

forming an opening on the first dielectric layer and second dielectric layer, exposing the eleventhfirst conductive layer, the twelfthsecond conductive layer, the thirteenththird conductive layer, fourteenthfourth conductive layer, fifteenthfifth conductive layer, the sixteenthsixth conductive layer, the seventeenthseventh conductive layer and the eighteentheighth conductive layer;

implantingforming a conductive plug in the opening, to penetrate the first dielectric layer and the second dielectric layer; and

forming a nineteenthninth conductive layer, a twentiethtenth conductive layer, an twenty firsteleventh conductive layer, twenty secondtwelfth conductive layer, a twenty thirdthirteenth conductive layer, a twenty fourthfourteenth conductive layer, a twenty fifthfifteenth conductive layer, a twenty sixthsixteenth conductive layer, a twenty seventhseventeenth conductive layer and an twenty eighteighteenth conductive layer on part of the second dielectric layer, wherein a eleventhfirst conductive plug is electrically connected to the fifteenthfifth conductive layer and nineteenthninth conductive layer, a twelfthsecond conductive plug is electrically connected to the eleventhfirst conductive layer and the twentiethtenth conductive layer, a thirteenththird conductive plug is electrically connected to the twenty sixthsixteenth conductive layer and the twelfthsecond conductive layer, a fourteenthfourth conductive plug is electrically connected to the twenty seventhseventeenth conductive layer and the sixteenthsixth conductive layer, a fifteenthfifth conductive plug is electrically connected to the twenty firsteleventh conductive layer and the thirteenththird conductive layer, a sixteenthsixth conductive plug is electrically connected to the twenty secondtwelfth conductive layer and the seventeenthseventh conductive layer, a seventeenthseventh conductive plug is electrically connected to the twenty fourthfourteenth conductive layer and eighteentheighth conductive layer, and an eighteentheighth conductive plug is electrically connected to the twenty fifthfifteenth conductive layer and the fourteenthfourth conductive layer.

27. (new) A processing method for a fuse structure, the method comprising:

- providing a substrate;
- forming a first conductor, a second conductor and a first dielectric layer on the substrate, wherein the first conductor and the second conductor are disposed between the substrate and the first dielectric layer;

forming a third conductor, a fourth conductor and a second dielectric layer on the first dielectric layer, wherein the third conductor and the fourth conductor are disposed between the second dielectric layer and the first dielectric layer;

forming a plurality of openings to expose the first conductor, the second conductor, the third conductor and the fourth conductor;

forming a conductive plug within each opening of the plurality of openings;

forming a fifth conductor on the second dielectric layer to be in electrical contact with the fourth conductor through the conductive plug within one of the opening of the plurality of openings;

forming a sixth conductor on the second dielectric layer to be in electrical contact with the second conductor through the conductive plug within one of the opening of the plurality of openings;

forming a seventh conductor on the second dielectric layer;

forming an eighth conductor on the second dielectric layer to be in electrical contact with the first conductor through the conductive plug within one of the opening of the plurality of openings;

forming a ninth conductor on the second dielectric layer to be in electrical contact with the third conductor through the conductive plug within one of the opening of the plurality of openings; and

forming a tenth conductor on the second dielectric layer.

28. (new) A processing method for a fuse structure, the method comprising:

providing a substrate;

forming a first conductor, a second conductor, a third conductor, a fourth conductor and a first dielectric layer on the substrate, wherein the first conductor, the second conductor, the third conductor and the fourth conductor are disposed between the substrate and the first dielectric layer;

forming a fifth conductor, a sixth conductor, a seventh conductor, an eighth conductor and a second dielectric layer on the first dielectric layer, wherein the fifth conductor, the sixth conductor, the seventh conductor and the eighth

conductor are disposed between the second dielectric layer and the first dielectric layer;

forming a plurality of openings to expose the first conductor, the second conductor, the third conductor, the fourth conductor, the fifth conductor, the sixth conductor, the seventh conductor and the eighth conductor;

forming a conductive plug within each opening of the plurality of openings;

forming a ninth conductor on the second dielectric layer to be in electrical contact with the fifth conductor through the conductive plug within one of the opening of the plurality of openings;

forming a tenth conductor on the second dielectric layer to be in electrical contact with the first conductor through the conductive plug within one of the opening of the plurality of openings;

forming an eleventh conductor on the second dielectric layer to be in electrical contact with the third conductor through the conductive plug within one of the opening of the plurality of openings;

forming a twelfth conductor on the second dielectric layer to be in electrical contact with the seventh conductor through the conductive plug within one of the opening of the plurality of openings;

forming a thirteenth conductor on the second dielectric layer;

forming a fourteenth conductor on the second dielectric layer to be in electrical contact with the eighth conductor through the conductive plug within one of the opening of the plurality of openings;

forming a fifteenth conductor on the second dielectric layer to be in electrical contact with the fourth conductor through the conductive plug within one of the opening of the plurality of openings;

forming a sixteenth conductor on the second dielectric layer to be in electrical contact with the second conductor through the conductive plug within one of the opening of the plurality of openings;

forming a seventeenth conductor on the second dielectric layer to be in electrical contact with the sixth conductor through the conductive plug within one of the opening of the plurality of openings; and

forming an eighteenth conductor on the second dielectric layer.